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Objective: Reporting on AM-PM effect at the output of the ADC3444 EVM module
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## Test setup:

TX: DAC3162EVM, Sampling Rate $=100 \mathrm{MHz}$
RX: ADC3444EVM, Sampling Rate $=100 \mathrm{MHz}$
SMA splitter
Single channel op-amp 6dB gain amplifier
Connecting the output of the TX DAC directly to RX ADC, without any analog filter, and using a single input-output amplifier and a splitter to derive a two separated receiving paths (figure 6). The theoretical result of the different of output assumed to be zero in phase, based on a two well-match PCB trace of the ADC Evaluation Module (EVM).

For DAC synthesis sinusoidal input with Matlab (figure 7)
S_ref = tx_power*sin( (2*pi*frequency*(1:tx_sampling_rate*sim_time)/tx_sampling_rate));
(\%frequency $=10 \mathrm{MHz}$ )


Figure 7

For ADC output capture (figure 8)

```
xbaseband_pd(1,:) = data(1,:).*exp(-1j*2*pi*frequency*(1:length(data(1,:))/rx_sampling_rate);
xbaseband_pd(2,:) = data(4,:).*exp(-1j*2*pi*frequency*(1:length(data(4,:))/rx_sampling_rate);
phase_diff = angle(mean(xbaseband_pd(2,:)))-angle(mean(xbaseband_pd(1,:)));
```

where data(n,:) are captured output from ADC channel 1 and $4(n=1,2)$, respectively.

| Calculated Phase_diff |  |  | tx_power in \% fullscale (500mv to 1Vp-p) |  |  |  |  |  |  |  |  |  |
| ---: | ---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| degree | radians | p10 | p20 | p30 | p40 | p50 | p60 | p70 | p80 | p90 | FS | Delta |
| 0.6 | 0.0500 | 0.0038 | 0.0037 | 0.0043 | 0.0044 | 0.0061 | 0.0064 | 0.0075 | 0.0083 | 0.0092 | 0.0102 |  |
| 1.2 | 0.1000 | 0.0130 | 0.0137 | 0.0137 | 0.0144 | 0.0153 | 0.0163 | 0.0174 | 0.0180 | 0.0193 | 0.0200 | 0.0070 |

Table 1
Captured ADC output of the phase difference
The differential phase value of 0.6 and 1.2 degree ( 0.05 and 0.10 radians) is hardcoded in the DAC pattern and each one is loaded onto the DAC via TSW1400, during each test case. The capture values (table 1) are then compared with the captured output at each input power level. The closest achievable measurement is shown in between p40 and p50. These measured value varies within a range of 0.0064 for 0.6 deg. case, and 0.0070 for 1.2 deg. case.

Issue:
Phase is computed independently of the input amplitude. This single-source input is fed onto both ch1 and ch4, the captured digitized sine waves at the output of the ADC contains an AM-PM effect which cannot be explained.


Figure 8 phase increases as input power incremented by $10 \%$

